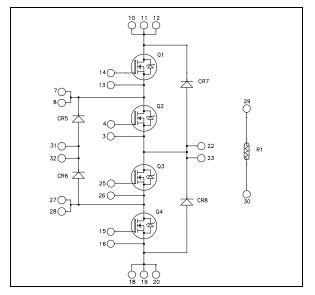


# Three level inverter SiC MOSFET Power Module

### SiC Power MOSFET:

 $V_{DSS} = 1200V ; R_{DSon} = 98m\Omega @ Tj = 25^{\circ}C$ 



#### **Application**

• Uninterruptible Power Supplies

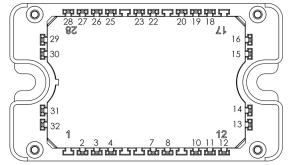
#### **Features**

#### • SiC Power MOSFET

- Low R<sub>DS(on)</sub>
- High temperature performance

#### SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring
- AlN substrate for improved thermal performance



## All multiple inputs and outputs must be shorted together 10/11/12; 7/8; 27/28; ...

#### **Benefits**

- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive TC of VCEsat
- Low profile
- RoHS Compliant

### All ratings @ $T_i = 25^{\circ}C$ unless otherwise specified

## Q1 to Q4 Absolute maximum ratings (per SiC MOSFET)

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Breakdown Voltage		1200	V
Ţ	Continuous Dusin Cumont	$T_c = 25^{\circ}C$	28	
$I_{\mathrm{D}}$	Continuous Drain Current	$T_c = 80^{\circ}C$	21	A
$I_{DM}$	Pulsed Drain current			
$V_{GS}$	Gate - Source Voltage	-10/+25	V	
R <sub>DSon</sub>	Drain - Source ON Resistance		98	mΩ
$P_D$	Maximum Power Dissipation	$T_c = 25$ °C	125	W

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



## Q1 to Q4 Electrical Characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V$ , $V_{DS} = 120$	0V		12	100	μA
R <sub>DS(on)</sub>	Drain – Source on Resistance	$V_{GS} = 20V$	$T_j = 25^{\circ}C$		80	98	
		$I_D = 20A$	$T_j = 150$ °C		150	208	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 1mA$		1.7	2.2		V
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	1			250	nA

## Q1 to Q4 Dynamic Characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
$C_{iss}$	Input Capacitance	$V_{GS} = 0V$			950		
$C_{oss}$	Output Capacitance	$V_{DS} = 1000V$	$V_{DS} = 1000V$		80		pF
$C_{rss}$	Reverse Transfer Capacitance	f = 1MHz			6.5		
$Q_{g}$	Total gate Charge	$V_{GS} = 20V$			49		
$Q_{\mathrm{gs}}$	Gate – Source Charge	$V_{Bus} = 800V$			11		nC
$Q_{gd}$	Gate – Drain Charge	$I_D = 20A$			18		
$T_{d(on)}$	Turn-on Delay Time	$\begin{array}{c} V_{GS} = -2/+20V \\ V_{Bus} = 800V \\ I_D = 20A \\ R_L = 40\Omega \; ; \; R_G = 50\Omega \end{array}$			12		
$T_{\rm r}$	Rise Time				14		
$T_{d(off)}$	Turn-off Delay Time				23		ns
$T_{\mathrm{f}}$	Fall Time				18		
Eon	Turn on Energy	$V_{Bus} = 600V$	$T_j = 150$ °C		0.45		mJ
$E_{\text{off}}$	Turn off Energy		$T_j = 150$ °C		0.25		111,3
$R_{thJC}$	Junction to Case Thermal Resistance	e				1	°C/W

## CR5 & CR6 SiC diode ratings and characteristics (Per SiC diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit	
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage			600			V	
T	Mariana Danama Laslana Garant	$V_{\rm p} = 600 V$	$T_j = 25$ °C		10	60	4	
$I_{RM}$	Maximum Reverse Leakage Current		$V_R = 600 V$	$V_{R} = 600 V$ $T_{i} = 175^{\circ} C$	$T_j = 175$ °C		20	300
$I_F$	DC Forward Current		Tc = 125°C		10		Α	
W	$V_F$ Diode Forward Voltage $I_F = 10A$	$T_i = 10$	$T_i = 25^{\circ}C$		1.6	1.8	V	
<b>V</b> F		$T_i = 175$ °C		2	2.4	V		
$Q_{\rm C}$	Total Capacitive Charge	$I_F = 10A, V_R = 600V$			28		nC	
		$di/dt = 500A/\mu s$						
С	Total Capacitance	$f = 1 MHz, V_R = 200 V$			65		рF	
		$f = 1MHz, V_R =$	400V		50		P	
$R_{thJC}$	Junction to Case Thermal Resistance					2.2	°C/W	



## CR7 & CR8 diode ratings and characteristics (Per SiC diode) Symbol Characteristic Test Conditions

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage			1200			V
$I_{RM}$	Maximum Reverse Leakage Current	V <sub>R</sub> =1200V	$T_j = 25$ °C		64	400	μА
			$T_{\rm j} = 175^{\circ}{\rm C}$		112	2000	
$I_F$	DC Forward Current		Tc = 125°C		20		A
$V_{\mathrm{F}}$	Diode Forward Voltage	$I_n = 200\Delta$	$T_i = 25$ °C		1.6	1.8	V
V <sub>F</sub>			$T_{i} = 175^{\circ}C$		2.3	3	V
$Q_{\rm C}$	Total Capacitive Charge	$I_F = 20A, V_R = 1200V$ $di/dt = 1000A/\mu s$			160		nC
С	T. 4.1 Committee	$f = 1MHz, V_R = 200V$		192		nF.	
	Total Capacitance $f = 1 \text{MHz}, V_R = 400$		= 400V		138		pF
$R_{thJC}$	Junction to Case Thermal Resistance					0.8	°C/W

## $Temperature\ sensor\ NTC\ (\text{see application note APT0406 on www.microsemi.com}\ ).$

Symbol	Characteristic		Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
$B_{25/85}$	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta \mathrm{B/B}$	Γ	T <sub>C</sub> =100°C		4		%

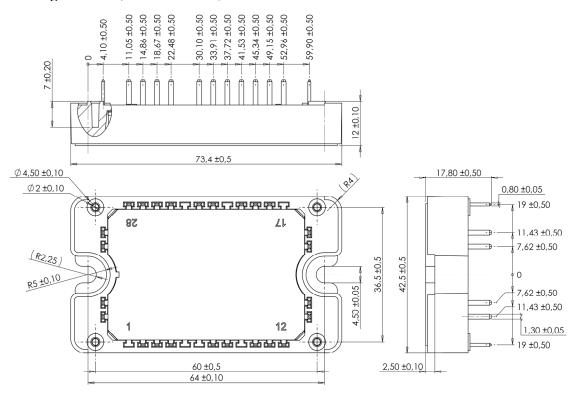
$$R_{T} = \frac{R_{25}}{\exp \left[ B_{25/85} \left( \frac{1}{T_{25}} - \frac{1}{T} \right) \right]}$$
 T: Thermistor temperature R<sub>T</sub>: Thermistor value at T

### Thermal and package characteristics Symbol Characteristic

V <sub>ISOL</sub> RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz  T <sub>J</sub> Operating junction temperature range	4000 -40		V
T. Operating junction temperature range	-40		
		150	]
SiC Diode	-40	175	
T <sub>JOP</sub> Recommended junction temperature under switching conditions	-40	T <sub>J</sub> max -25	°C
T <sub>STG</sub> Storage Temperature Range	-40	125	]
T <sub>C</sub> Operating Case Temperature	-40	125	
Torque   Mounting torque   To heatsink   M4	2	3	N.m
Wt Package Weight		110	g

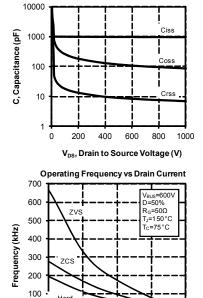


### SP3 Package outline (dimensions in mm)



See application note 1906 - Mounting Instructions for SP3F Power Modules on www.microsemi.com

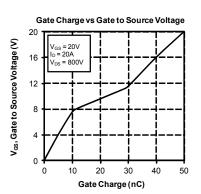
### Q1 to Q4 Typical performance curve



15 20 25 I<sub>D</sub>, Drain Current (A)

10

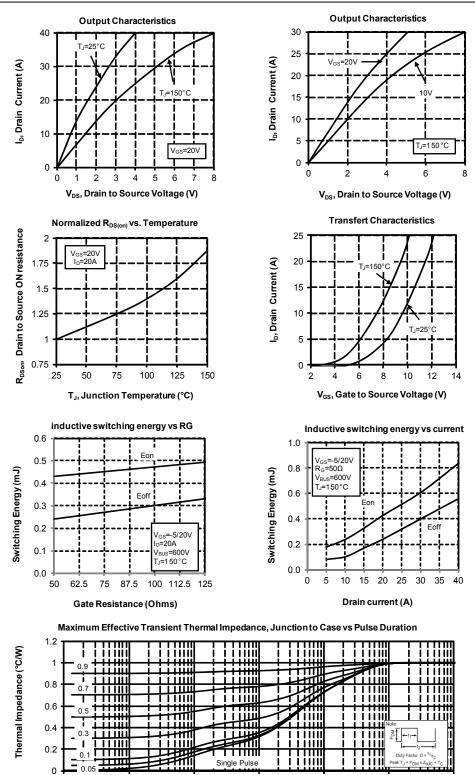
Capacitance vs Drain to Source Voltage





0.00001

## APTMC60TL11CT3AG



0.01

rectangular Pulse Duration (Seconds)

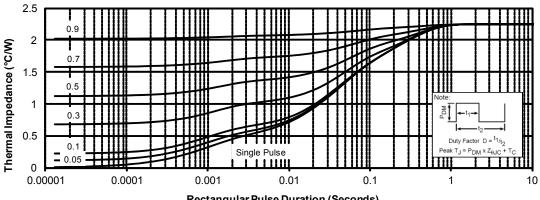
0.001

0.0001

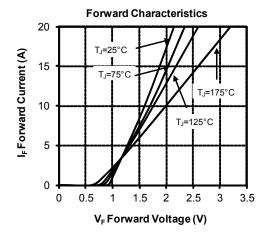


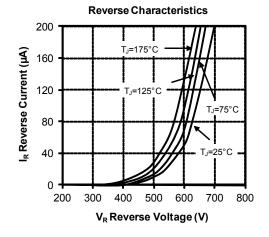
## CR5 & CR6 Typical performance curve

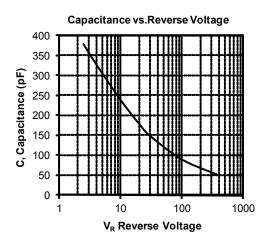
#### Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



Rectangular Pulse Duration (Seconds)



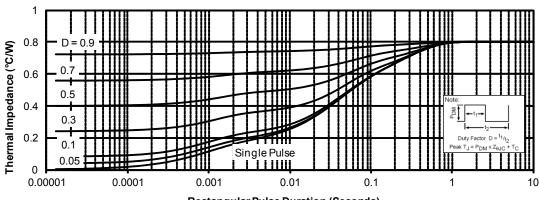




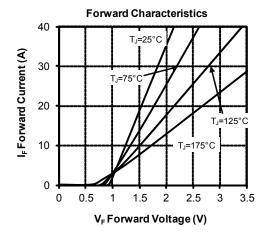


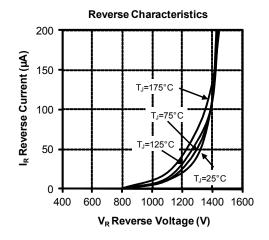
## CR7 & CR8 Typical performance curve

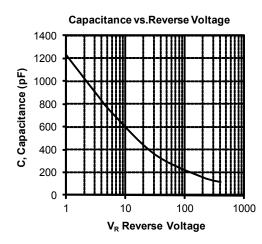
#### Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



Rectangular Pulse Duration (Seconds)







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